

<b>Notice of References Cited</b>	Application/Control No. 10/627,277	Applicant(s)/Patent Under Reexamination KIM, TAE W.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0137294 A1	09-2002	Wu et al.	438/289
	B	US-3,859,222	01-1975	Squillace et al.	252/79.3
	C	US-5,384,279	01-1995	Stolmeijer et al.	438/217
	D	US-5,698,461	12-1997	Liu, Ming-Hua	438/291
	E	US-5,750,430	05-1998	Son, Jeong-Hwan	438/303
	F	US-5,786,256	07-1998	Gardner et al.	438/305
	G	US-5,856,225	01-1999	Lee et al.	438/291
	H	US-5,877,056	03-1999	Wu, Shye-Lin	438/291
	I	US-5,960,270	09-1999	Misra et al.	438/197
	J	US-6,117,739	09-2000	Gardner et al.	438/289
	K	US-6,159,808	12-2000	Chuang, Shu-Ya	438/291
	L	US-6,177,336	01-2001	Lin et al.	438/592
	M	US-6,180,468 B1	01-2001	Yu et al.	438/297

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,200,865 B1	03-2001	Gardner et al.	438/291
	B	US-6,204,148 B1	03-2001	Gardner et al.	438/430
	C	US-6,251,760 B1	06-2001	Son, Jeong-Hwan	438/585
	D	US-6,300,201 B1	10-2001	Shao et al.	438/281
	E	US-6,344,397 B1	02-2002	Horstmann et al.	438/300
	F	US-6,395,606 B1	05-2002	Huster et al.	438/289
	G	US-6,410,394 B1	06-2002	Shao et al.	438/289
	H	US-6,518,113 B1	02-2003	Buynoski, Matthew S.	438/217
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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